

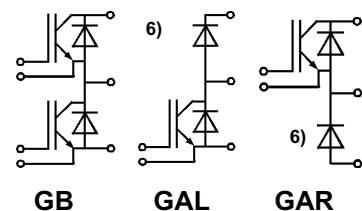
Absolute Maximum Ratings		Values	
Symbol	Conditions ¹⁾		Units
V_{CES}		1200	V
V_{CGR}	$R_{GE} = 20 \text{ k}\Omega$	1200	V
I_C	$T_{case} = 25/80 \text{ }^\circ\text{C}$	200 / 160	A
I_{CM}	$T_{case} = 25/80 \text{ }^\circ\text{C}; t_p = 1 \text{ ms}$	400 / 320	A
V_{GES}		± 20	V
P_{tot}	per IGBT, $T_{case} = 25 \text{ }^\circ\text{C}$	1380	W
$T_j, (T_{stg})$		-40 ... +150 (125)	$^\circ\text{C}$
V_{isol}	AC, 1 min.	2500	V
humidity	IEC 60721-3-3	class 3K7/IE32	
climate	IEC 68 T.1	40/125/56	
Inverse Diode			
$I_F = -I_C$	$T_{case} = 25/80 \text{ }^\circ\text{C}$	200 / 130	A
$I_{FM} = -I_{CM}$	$T_{case} = 25/80 \text{ }^\circ\text{C}; t_p = 1 \text{ ms}$	400 / 320	A
I_{FSM}	$t_p = 10 \text{ ms}; \sin.; T_j = 150 \text{ }^\circ\text{C}$	1450	A
I^{2t}	$t_p = 10 \text{ ms}; T_j = 150 \text{ }^\circ\text{C}$	10 500	A^2s

SEMITRANS® M Ultra Fast IGBT Modules

SKM 200 GB 125 D
SKM 200 GAL 125 D⁶⁾
SKM 200 GAR 125 D⁶⁾



SEMITRANS 3



Features

- N channel, homogeneous Si
- Low inductance case
- **Short tail** current with low temperature dependence
- High short circuit capability, self limiting to $6 * I_{nom}$
- Fast & soft inverse CAL diodes ⁸⁾
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (13 mm) and creepage distances (20 mm)

Typical Applications

- Switched mode power supplies at $f_{sw} > 20 \text{ kHz}$
- Resonant inverters up to 100 kHz
- Inductive heating
- Electronic welders at $f_{sw} > 20 \text{ kHz}$

¹⁾ $T_{case} = 25 \text{ }^\circ\text{C}$, unless otherwise specified

²⁾ $I_F = -I_C$, $V_R = 600 \text{ V}$, $-di_F/dt = 1500 \text{ A}/\mu\text{s}$, $V_{GE} = 0 \text{ V}$

³⁾ Use $V_{GEoff} = -5 \dots -15 \text{ V}$

⁶⁾ The free-wheeling diodes of the GAL and GAR type have the same data as the inverse Diodes of SKM 200 GA 125 D

⁸⁾ CAL = Controlled Axial Lifetime Technology

Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
$V_{(BR)CES}$	$V_{GE} = 0$, $I_C = 4 \text{ mA}$	$\geq V_{CES}$			V
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 6 \text{ mA}$	4,5	5,5	6,5	V
I_{CES}	$V_{GE} = 0$ { $T_j = 25 \text{ }^\circ\text{C}$ $V_{CE} = V_{CES}$ } $T_j = 125 \text{ }^\circ\text{C}$	0,2	3	12	mA
I_{GES}	$V_{GE} = 20 \text{ V}$, $V_{CE} = 0$			1	μA
V_{CEsat}	$I_C = 150 \text{ A}$ { $V_{GE} = 15 \text{ V}$; } $I_C = 200 \text{ A}$ { $T_j = 25 \text{ }^\circ\text{C}$ }	3,3	3,85	3,8	V
g_{fs}	$V_{CE} = 20 \text{ V}$, $I_C = 150 \text{ A}$	95			S
C_{CHC}	per IGBT			700	pF
C_{ies}	{ $V_{GE} = 0$ $V_{CE} = 25 \text{ V}$ }	10	13		nF
C_{oes}		1,5	2		nF
C_{res}	{ $f = 1 \text{ MHz}$ }	0,8	1,2		nF
L_{CE}				20	nH
$t_{d(on)}$	{ $V_{CC} = 600 \text{ V}$ $V_{GE} = -15 \text{ V} / +15 \text{ V}^3)$	75			ns
t_r		36			ns
$t_{d(off)}$	{ $I_C = 150 \text{ A}$, ind. load $R_{Gon} = R_{Goff} = 4 \Omega$	420			ns
t_f		25			ns
E_{on}	{ $T_j = 125 \text{ }^\circ\text{C}$ }	14			mWs
E_{off}		8			mWs
Inverse Diode ^{8) 6)}					
$V_F = V_{EC}$	{ $I_F = 150 \text{ A}$ { $V_{GE} = 0 \text{ V}$; } $I_F = 200 \text{ A}$ { $T_j = 25 \text{ (125) }^\circ\text{C}$ }}	2,0(1,8) 2,25(2,05)	2,5		V
V_{TO}	$T_j = 125 \text{ }^\circ\text{C}$ ²⁾			1,2	V
r_t	$T_j = 125 \text{ }^\circ\text{C}$ ²⁾	5	7		$\text{m}\Omega$
I_{RRM}	$I_F = 150 \text{ A}$; $T_j = 25 \text{ (125) }^\circ\text{C}$ ²⁾	55(80)			A
Q_{rr}	$I_F = 150 \text{ A}$; $T_j = 25 \text{ (125) }^\circ\text{C}$ ²⁾	8(20)			μC
Thermal characteristics					
R_{thjc}	per IGBT		0,09		$^\circ\text{C}/\text{W}$
R_{thjc}	per diode		0,25		$^\circ\text{C}/\text{W}$
R_{thch}	per module		0,038		$^\circ\text{C}/\text{W}$

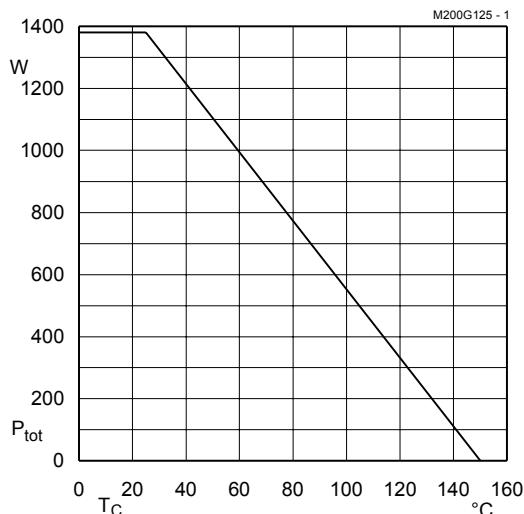


Fig. 1 Rated power dissipation $P_{tot} = f (T_C)$

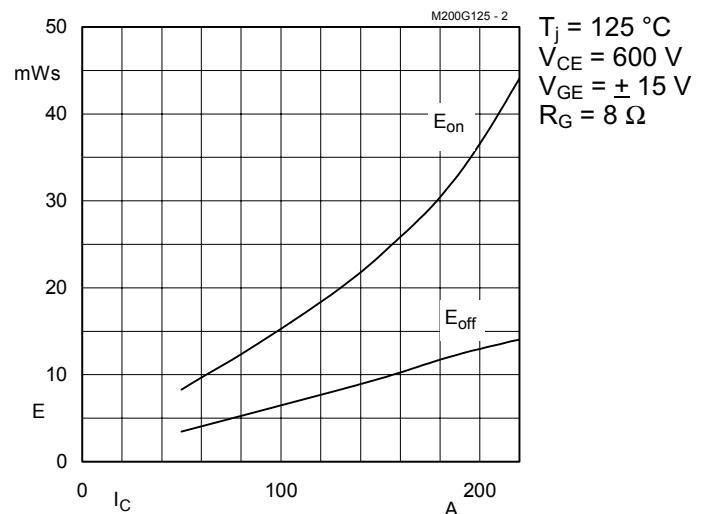


Fig. 2 Turn-on /-off energy = f (I_C)

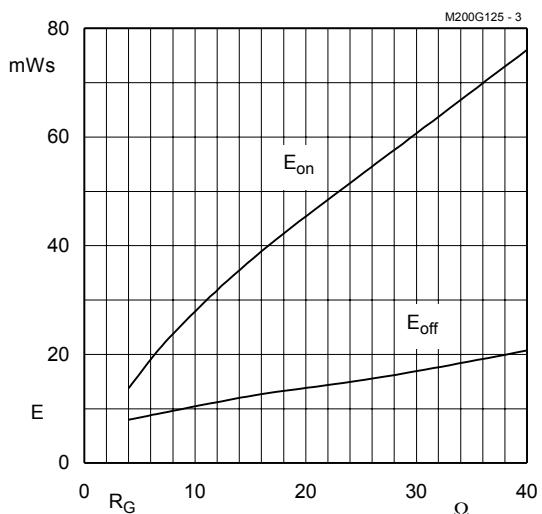


Fig. 3 Turn-on /-off energy = f (R_G)

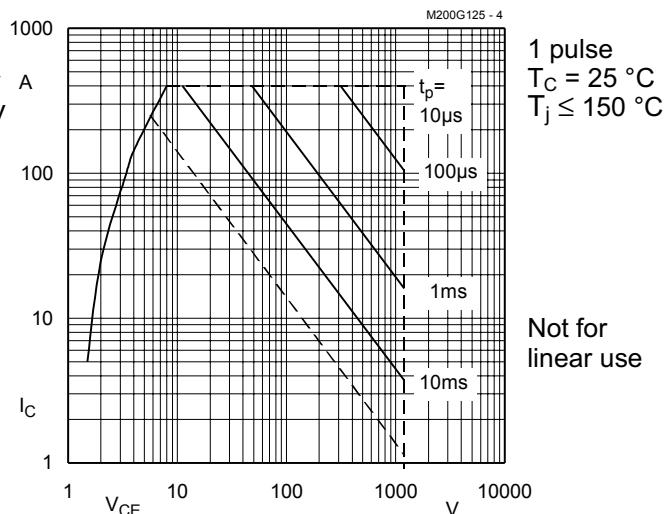


Fig. 4 Maximum safe operating area (SOA) $I_C = f (V_{CE})$

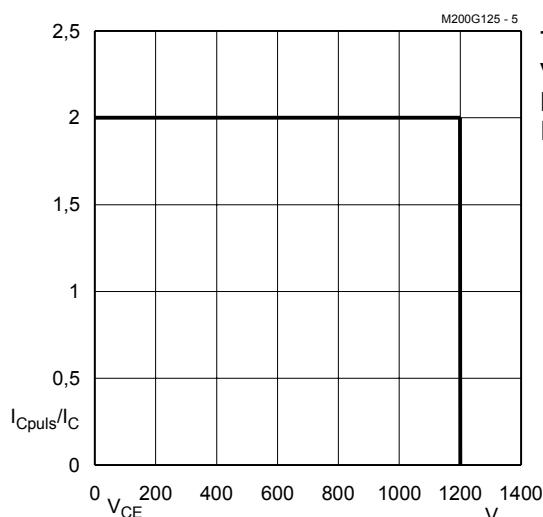


Fig. 5 Turn-off safe operating area (RBSOA)

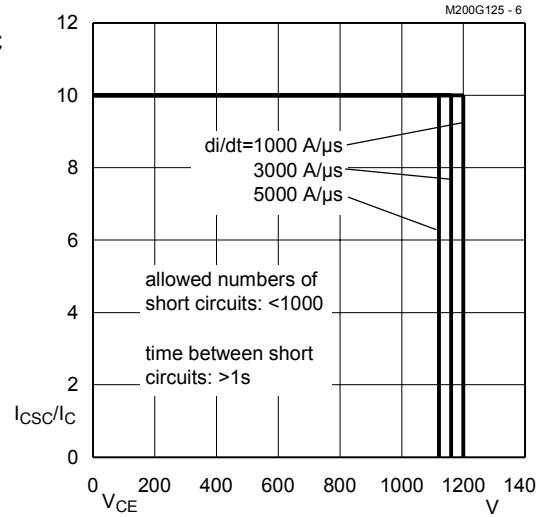


Fig. 6 Safe operating area at short circuit $I_C = f (V_{CE})$

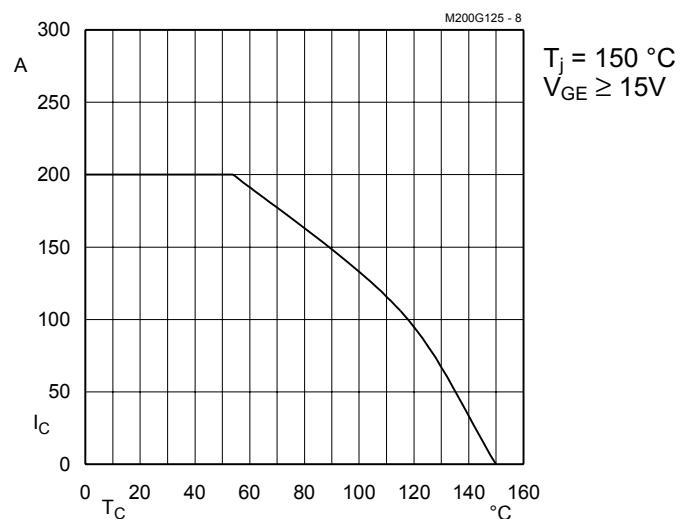


Fig. 8 Rated current vs. temperature $I_C = f (T_C)$

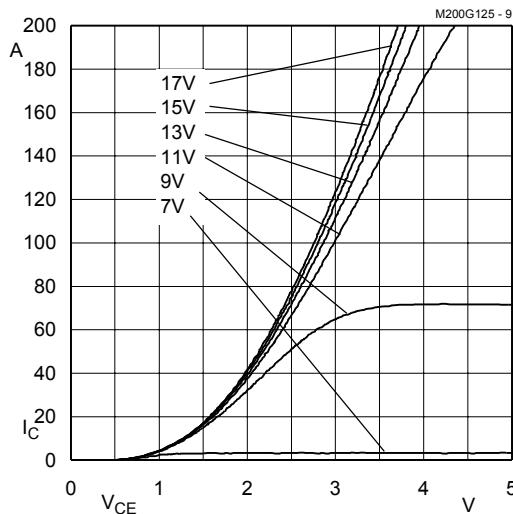


Fig. 9 Typ. output characteristic, $t_p = 80 \mu s$; 25 °C

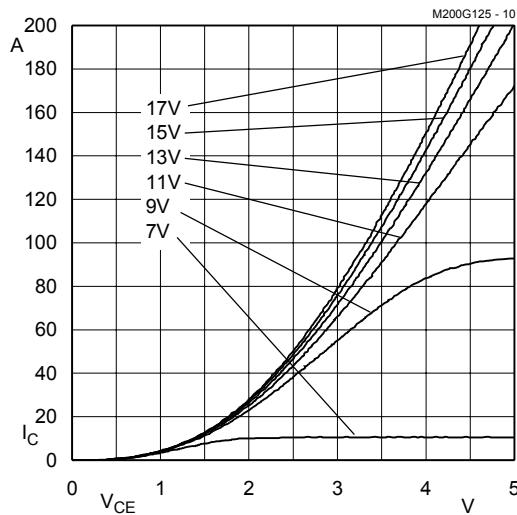


Fig. 10 Typ. output characteristic, $t_p = 80 \mu s$; 125 °C

$$P_{cond(t)} = V_{CEsat(t)} \cdot I_{C(t)}$$

$$V_{CEsat(t)} = V_{CE(TO)(Tj)} + r_{CE(Tj)} \cdot I_{C(t)}$$

$$V_{CE(TO)(Tj)} \leq 1,4 + 0,003 (T_j - 25) [V]$$

$$\text{typ.: } r_{CE(Tj)} = 0,0127 + 0,000033 (T_j - 25) [\Omega]$$

$$\text{max.: } r_{CE(Tj)} = 0,0153 + 0,000020 (T_j - 25) [\Omega]$$

valid for $V_{GE} = + 15^{+2}_{-1}$ [V]; $I_C > 0,3 I_{Cnom}$

Fig. 11 Saturation characteristic (IGBT)
Calculation elements and equations

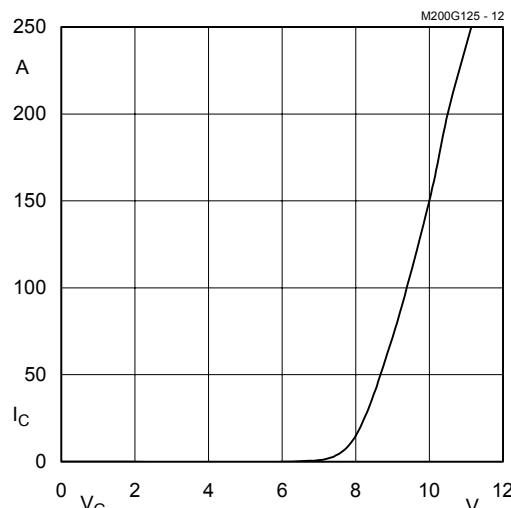


Fig. 12 Typ. transfer characteristic, $t_p = 80 \mu s$; $V_{CE} = 20 V$

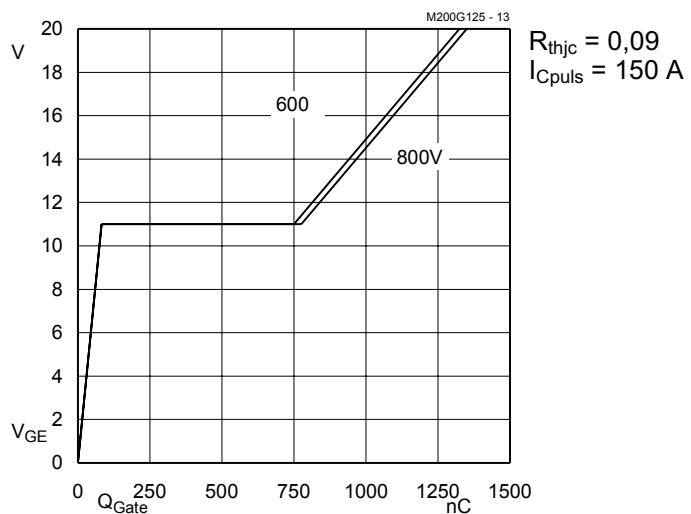


Fig. 13 Typ. gate charge characteristic

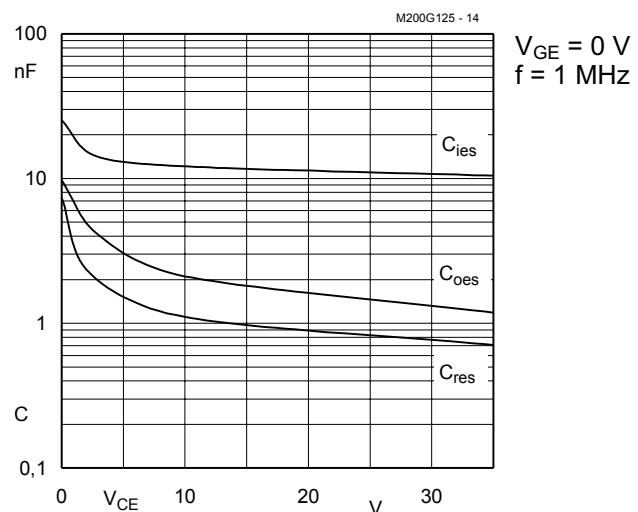


Fig. 14 Typ. capacitances vs. V_{CE}

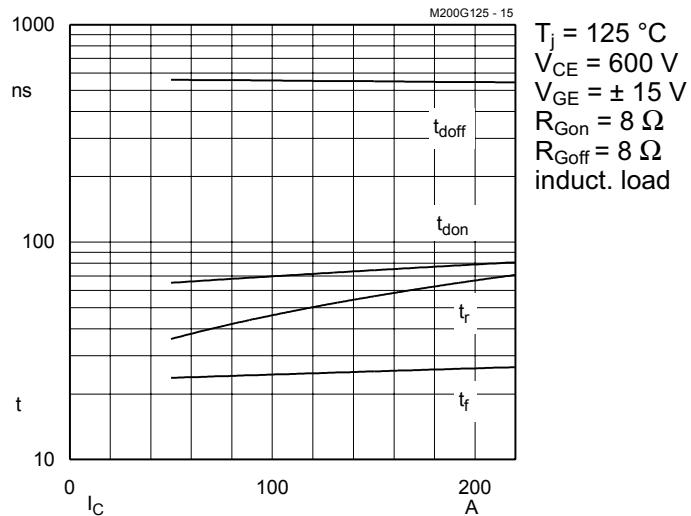


Fig. 15 Typ. switching times vs. I_C

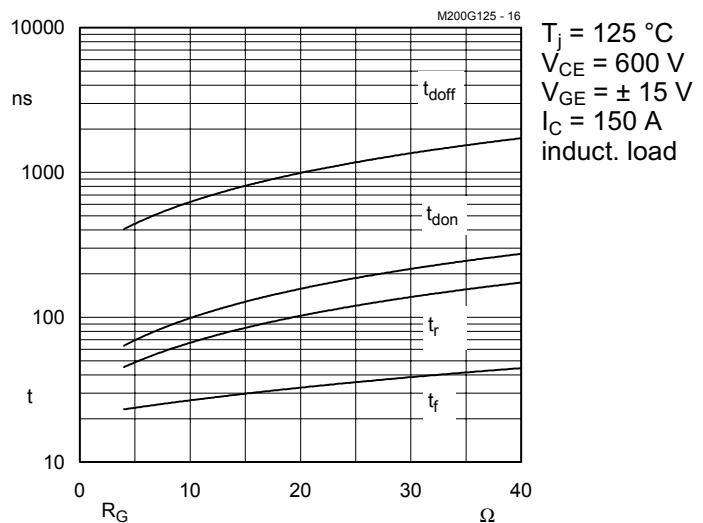


Fig. 16 Typ. switching times vs. gate resistor R_G

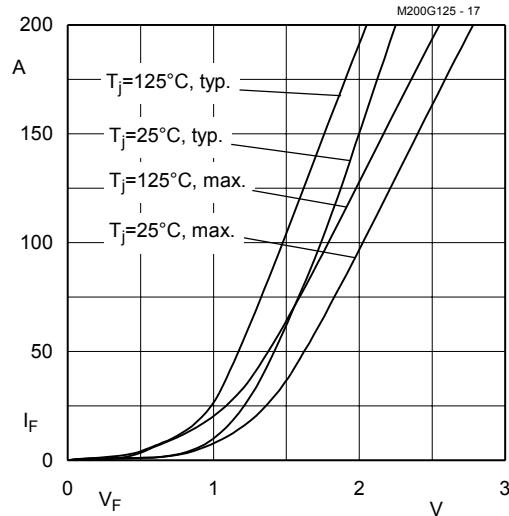


Fig. 17 Typ. CAL diode forward characteristic

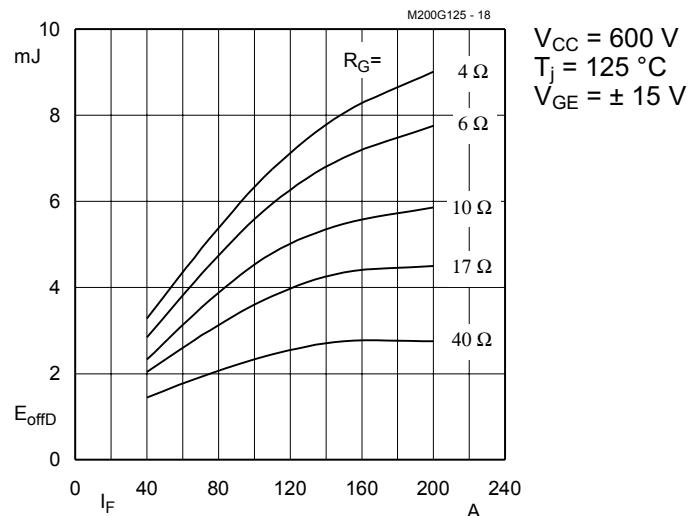


Fig. 18 Diode turn-off energy dissipation per pulse

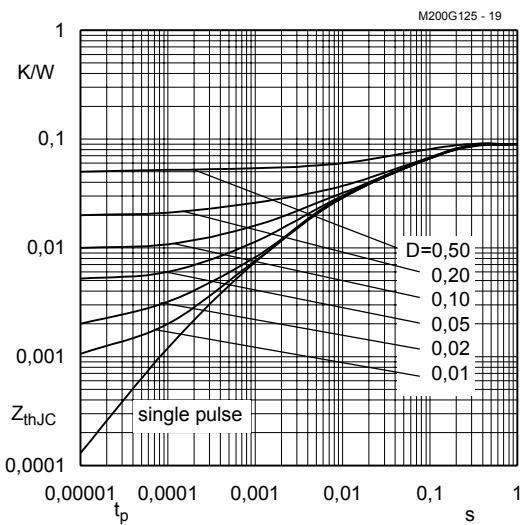


Fig. 19 Transient thermal impedance of IGBT
 $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

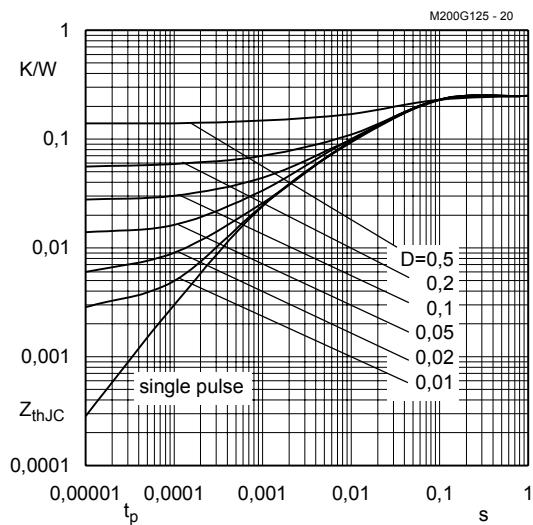


Fig. 20 Transient thermal impedance of
 inverse CAL diodes $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

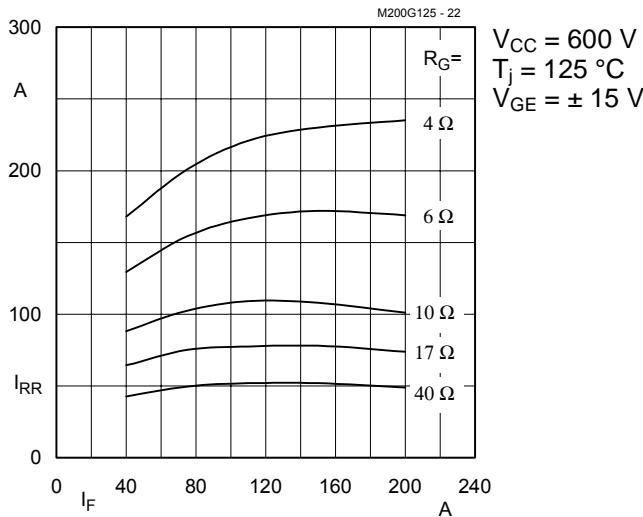


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

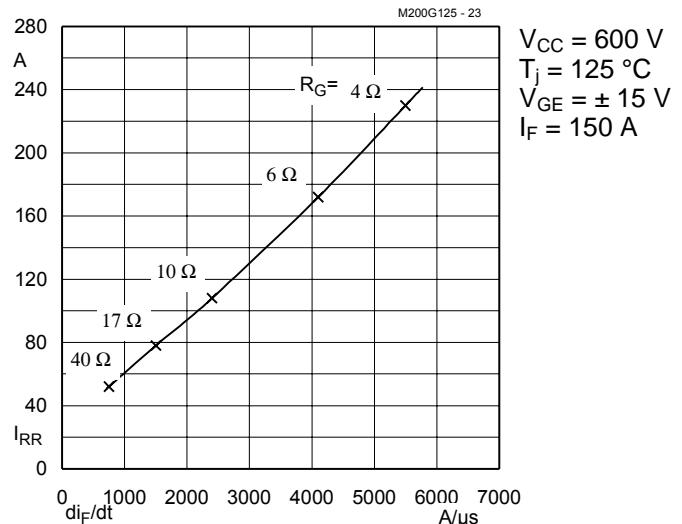


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di/dt)$

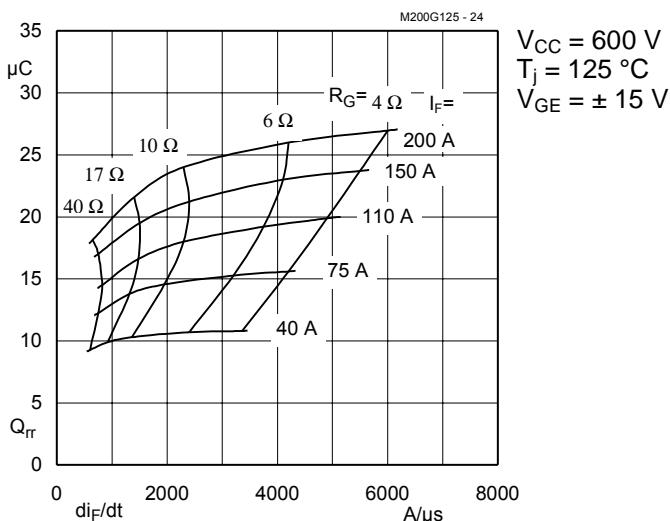


Fig. 24 Typ. CAL diode recovered charge

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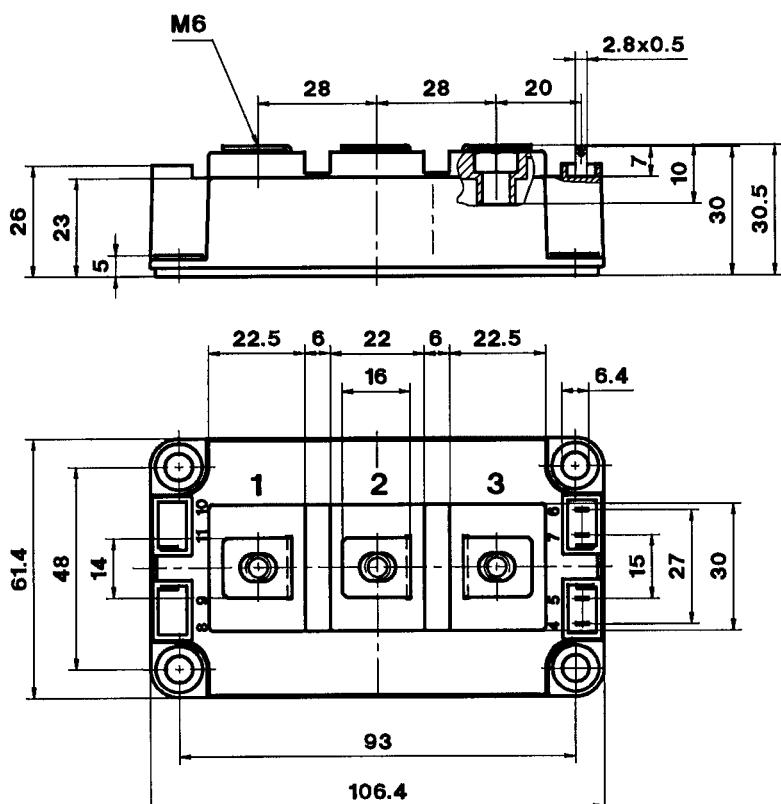
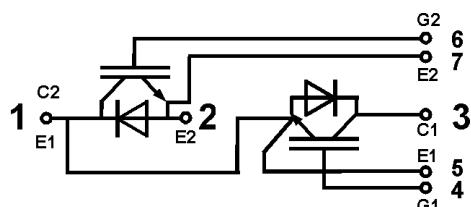
Case D 56

UL Recognized

File no. E 63 532

CASED56

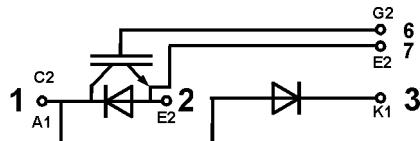
SKM 200 GB 125 D



Dimensions in mm

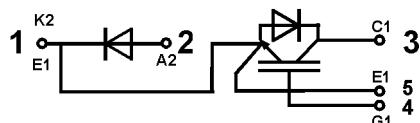
SKM 200 GAL 125 D

Case D 57 (→ D 56)



SKM 200 GAR 125 D

Case D 58 (→ D 56)



Case outline and circuit diagrams

⁶⁾ Free-wheeling diode → page 1, remark 6

Mechanical Data		Values	Units	
Symbol	Conditions			
M ₁	to heatsink, SI Units	(M6)	3	—
	to heatsink, US Units		27	—
M ₂	for terminals, SI Units	(M6)	2,5	—
	for terminals, US Units		22	—
a			—	5x9,81
w			—	325
				g

**This is an electrostatic discharge
sensitive device (ESDS).
Please observe the international
standard IEC 747-1, Chapter IX.**

Twelve devices are supplied in one SEMIBOX D without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 3).

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